



AF/IFW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventor Applicant:

Tsung-Ein Tsai et al.

Serial No.: 10/608,726

Filed: June 27, 2003

For: Measuring Coupling Characteristics  
of Optical Devices

§  
§  
§  
§  
§  
§  
§  
§  
§

Art Unit: 2883

Examiner: Eric K. Wong

Docket: ITL.0877US  
P15106

Assignee: Intel Corporation

Mail Stop AF  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**REPLY TO FINAL REJECTION**

Sir:

In response to the final rejection mailed June 30, 2005, reconsideration is respectfully requested in view of the following remarks.

Date of Deposit: July 14, 2005

I hereby certify under 37 CFR 1.8(a) that this correspondence is being deposited with the United States Postal Service as **first class mail** with sufficient postage on the date indicated above and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

*Cynthia L. Hayden*  
Cynthia L. Hayden